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FQD6N60C 600V N-Channel MOSFET

Features

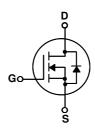
- 4 A, 600 V, $R_{DS(on)}$ = 2.0 Ω @ V_{GS} = 10 V
- Low gate charge (typical 16 nC)
- Low Crss (typical 7 pF)
- · Fast switching
- 100 % avalanche tested
- · Improved dv/dt capability

Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction, electronic lamp ballasts based on half bridge topology.





Absolute Maximum Ratings

Symbol	Parameter			FQD6N60C	Units
V _{DSS}	Drain-Source Voltage			600	V
I _D	Drain Current - Continuous (T _C = 25°C)		°C)	4	А
		- Continuous (T _C = 100	0°C)	2.4	А
I _{DM}	Drain Current	- Pulsed	(Note 1)	16	А
V _{GSS}	Gate-Source Voltage			± 30	V
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	300	mJ
I _{AR}	Avalanche Current		(Note 1)	4.0	A
E _{AR}	Repetitive Avalanche Energy		(Note 1)	8.0	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	4.5	V/ns
P _D	Power Dissipation (T _C = 25°C)			80	W
	- Derate above 25°C			0.78	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		nge	-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		g purposes,	300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		1.56	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		110	°C/W

* When mounted on the minimum pad size recommended (PCB Mount)

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FQD6N60C	FQD6N60CTM	DPAK	380mm	16mm	2500
FQD6N60C	FQD6N60CTF	DPAK	380mm	16mm	2000

Electrical Characteristics $T_C = 25$ °C unless otherwise noted

Symbol	Parameter Test Conditions		Min.	Тур.	Max.	Units
Off Characte	ristics					
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	600			V
$\Delta BV_{DSS}/$ ΔT_J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		0.6		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	Sate Voltage Drain Current V_{DS} = 600 V, V_{GS} = 0 V			1	μΑ
		V _{DS} = 480 V, T _C = 125°C			10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Characte	ristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 2.0 A		1.7	2.0	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 2.0 A (Note 4)		4.8		S
Dynamic Cha	aracteristics					
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$		620	810	pF
C _{oss}	Output Capacitance	f = 1.0 MHz		65	85	pF
C _{rss}	Reverse Transfer Capacitance			7	10	pF
Switching Ch	naracteristics					
t _{d(on)}	Turn-On Delay Time	V _{DD} = 300 V, I _D = 5.5 A,		15	40	ns
t _r	Turn-On Rise Time	$R_{G} = 25 \Omega$		45	100	ns
t _{d(off)}	Turn-Off Delay Time	7		45	100	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		45	100	ns
Q _g	Total Gate Charge	V _{DS} = 480 V, I _D = 5.5 A,		16	20	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V		3.5		nC
Q _{gd}	Gate-Drain Charge	(Note 4, 5)	-	6.5		nC
Drain-Source	e Diode Characteristics and Maximum R	atings				
I _S	Maximum Continuous Drain-Source Diode Forward Current				4.0	А
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				16	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 4.0 A			1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 5.5 A,		310		ns
Q _{rr}	Reverse Recovery Charge	$dI_F / dt = 100 \text{ A/}\mu\text{s} \qquad (Note 4)$		2.1		μС
-						

Notes

- ${\bf 1.}\ {\bf Repetitive}\ {\bf Rating: Pulse\ width\ limited\ by\ maximum\ junction\ temperature}$
- 2. L = 34.3 mH, I $_{AS}$ = 4.0 A, V $_{DD}$ = 50V, R $_{G}$ = 25 Ω , Starting T $_{J}$ = 25°C
- 3. $I_{SD} \le 4.0$ A, di/dt ≤ 200 A/ μ s, $V_{DD} \le BV_{DSS}$, Starting T_J = 25°C
- 4. Pulse Test : Pulse width $\leq 300 \mu s, \ Duty \ cycle \leq 2\%$
- 5. Essentially independent of operating temperature

Typical Performance Characteristics

Figure 1. On-Region Characteristics

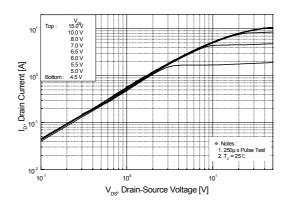


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

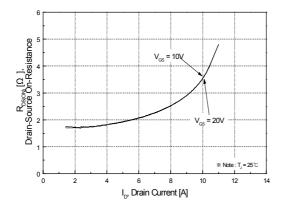


Figure 5. Capacitance Characteristics

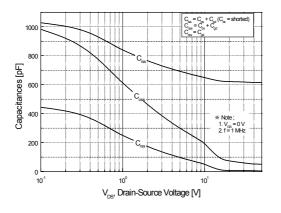


Figure 2. Transfer Characteristics

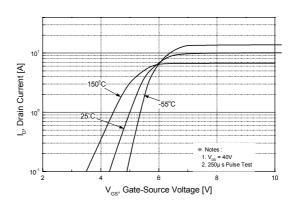


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

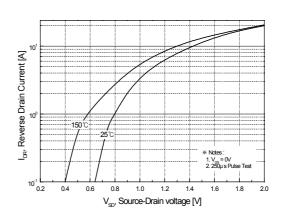
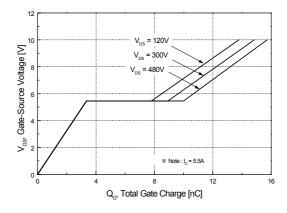


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

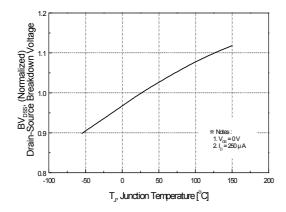


Figure 8. On-Resistance Variation vs. Temperature

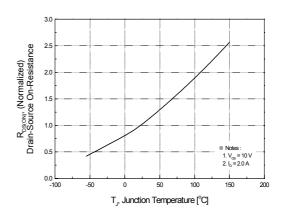
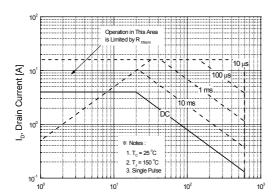


Figure 9. Maximum Safe Operating Area



V_{DS}, Drain-Source Voltage [V]

Figure 10. Maximum Drain Current vs. Case Temperature

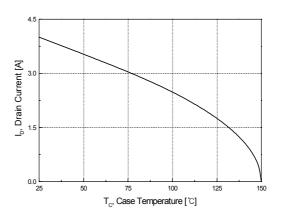
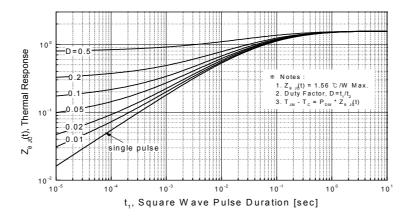
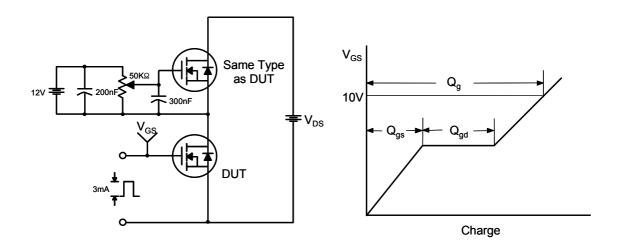


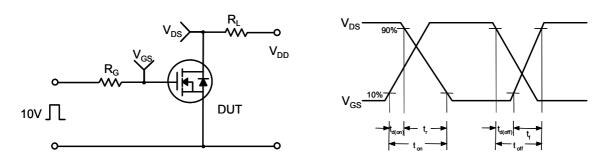
Figure 11. Transient Thermal Response Curve



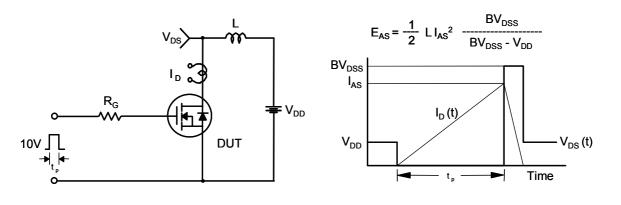
Gate Charge Test Circuit & Waveform



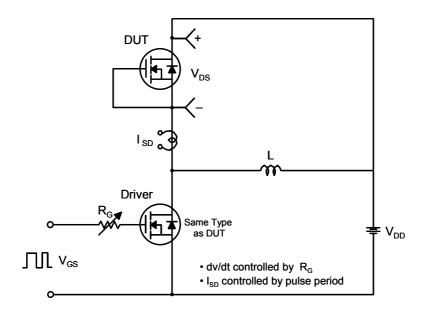
Resistive Switching Test Circuit & Waveforms

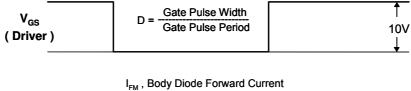


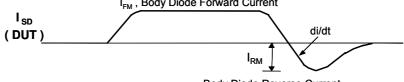
Unclamped Inductive Switching Test Circuit & Waveforms



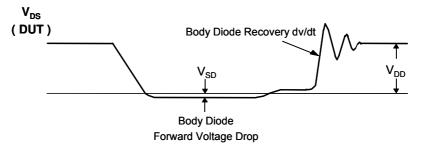
Peak Diode Recovery dv/dt Test Circuit & Waveforms





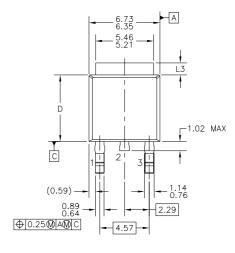


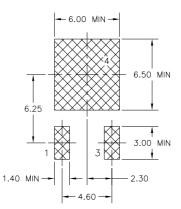
Body Diode Reverse Current



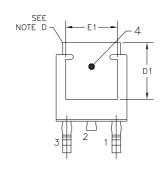
Mechanical Dimensions

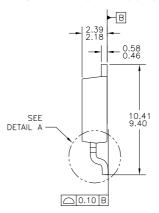
D-PAK

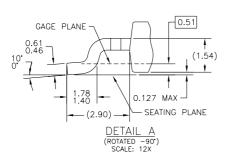




LAND PATTERN RECOMMENDATION







- NOTES: UNLESS OTHERWISE SPECIFIED

 A) ALL DIMENSIONS ARE IN MILLIMETERS.

 B) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE C, VARIATION AA & AB, DATED NOV. 1999.

 C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.

 D) HEAT SINK TOP EDGE COULD BE IN CHAMFERED CORNERS OR EDGE PROTRUSION.

 E) DIMENSIONS L3,DE &DI TABLE:

 FOPTION AA TOPTION AB |

DIMILITATIONS LOLD, LIGHT IN					
		OPTION AA	OPTION AB		
	L3	0.89-1.27	1.52-2.03		
	D	5.97-6.22	5.33-5.59		
	E1	4.32 MIN	3.81 MIN		
	D1	5.21 MIN	4.57 MIN		

PRESENCE OF TRIMMED CENTER LEAD IS OPTIONAL.

Dimensions in Millimeters

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EcoSPARK™	HiSeC™	MICROWIRE™	QS™	SyncFET™
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EnSigna™	i-Lo™	MSXPro™	Quiet Series™	TINYOPTO™
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FACT Quiet Series™		OCXPro™	RapidConnect™	UHC™
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Datasheet Identification	Product Status	Definition
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No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.

Rev. I15